

RADIO TEST REPORT

Test Report No. 15375714H-A-R1

Customer	Nintendo Co., Ltd.
Description of EUT	Wireless device
Model Number of EUT	CLO-001
FCC ID	BKECLO001
Test Regulation	FCC Part 15 Subpart C
Test Result	Complied
Issue Date	September 6, 2024
Remarks	24 GHz Sensor part

Representative test engineerYuichiro Yamazaki
Engineer**Approved by**Ryota Yamanaka
Engineer

CERTIFICATE 5107.02

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- ☒ There is no testing item of "Non-accreditation".

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REVISION HISTORY

Original Test Report No. 15375714H-A

This report is a revised version of 15375714H-A. 15375714H-A is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	15375714H-A	August 23, 2024	-
1	15375714H-A-R1	September 6, 2024	Change the Result value due to corrections of the AV calculation formula for Radiated Emission test data. (page 20).
1	15375714H-A-R1	September 6, 2024	Replaced the test data due to the correction of the PK and AV reading value and formula for Radiated Emission (Fundamental) test data (page 22, 23).
1	15375714H-A-R1	September 6, 2024	Addition of the LIMS ID: 142048 in Test instruments.

Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	ICES	Interference-Causing Equipment Standard
AC	Alternating Current	IEC	International Electrotechnical Commission
AFH	Adaptive Frequency Hopping	IEEE	Institute of Electrical and Electronics Engineers
AM	Amplitude Modulation	IF	Intermediate Frequency
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada
Ant, ANT	Antenna	ISO	International Organization for Standardization
AP	Access Point	JAB	Japan Accreditation Board
ASK	Amplitude Shift Keying	LAN	Local Area Network
Atten., ATT	Attenuator	LIMS	Laboratory Information Management System
AV	Average	MCS	Modulation and Coding Scheme
BPSK	Binary Phase-Shift Keying	MRA	Mutual Recognition Arrangement
BR	Bluetooth Basic Rate	N/A	Not Applicable
BT	Bluetooth	NIST	National Institute of Standards and Technology
BT LE	Bluetooth Low Energy	NS	No signal detect.
BW	BandWidth	NSA	Normalized Site Attenuation
Cal Int	Calibration Interval	NVLAP	National Voluntary Laboratory Accreditation Program
CCK	Complementary Code Keying	OBW	Occupied Band Width
Ch., CH	Channel	OFDM	Orthogonal Frequency Division Multiplexing
CISPR	Comite International Special des Perturbations Radioelectriques	P/M	Power meter
CW	Continuous Wave	PCB	Printed Circuit Board
DBPSK	Differential BPSK	PER	Packet Error Rate
DC	Direct Current	PHY	Physical Layer
D-factor	Distance factor	PK	Peak
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise
DQPSK	Differential QPSK	PRBS	Pseudo-Random Bit Sequence
DSSS	Direct Sequence Spread Spectrum	PSD	Power Spectral Density
EDR	Enhanced Data Rate	QAM	Quadrature Amplitude Modulation
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QP	Quasi-Peak
EMC	ElectroMagnetic Compatibility	QPSK	Quadri-Phase Shift Keying
EMI	ElectroMagnetic Interference	RBW	Resolution Band Width
EN	European Norm	RDS	Radio Data System
ERP, e.r.p.	Effective Radiated Power	RE	Radio Equipment
EU	European Union	RF	Radio Frequency
EUT	Equipment Under Test	RMS	Root Mean Square
Fac.	Factor	RSS	Radio Standards Specifications
FCC	Federal Communications Commission	Rx	Receiving
FHSS	Frequency Hopping Spread Spectrum	SA, S/A	Spectrum Analyzer
FM	Frequency Modulation	SG	Signal Generator
Freq.	Frequency	SVSWR	Site-Voltage Standing Wave Ratio
FSK	Frequency Shift Keying	TR	Test Receiver
GFSK	Gaussian Frequency-Shift Keying	Tx	Transmitting
GNSS	Global Navigation Satellite System	VBW	Video BandWidth
GPS	Global Positioning System	Vert.	Vertical
Hori.	Horizontal	WLAN	Wireless LAN

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SECTION 1: Customer information

Company Name	Nintendo Co., Ltd.
Address	11-1 Hokotate-cho, Kamitoba, Minami-ku, Kyoto 601-8501, Japan
Telephone Number	+81-75-662-9600
Contact Person	Hideki Ohashi

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

SECTION 2: Equipment under test (EUT)

2.1 Identification of EUT

Description	Wireless device
Model Number	CLO-001
Serial Number	Refer to SECTION 4.2
Condition	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	October 31 and December 12, 2023
Test Date	December 13, 2023 to April 1, 2024

2.2 Product Description

General Specification

Rating	DC 5 V
Operating temperature	5 deg. C to 35 deg. C

Radio Specification

WLAN (IEEE802.11b/11g/11n-20)

Equipment Type	Transceiver
Frequency of Operation	2412 MHz to 2472 MHz
Type of Modulation	DSSS, OFDM
Antenna Type	Inverted F Antenna
Antenna Gain	3.85 dBi
Receiver Category	1

24 GHz Sensor

Equipment Type	Transceiver
Frequency of Operation	24.150 GHz
Frequency range	24.059 GHz to 24.239 GHz
Modulation	FMCW
Antenna type	Patch Antenna
Antenna Gain	3.5 dBi
Steerable Antenna	None
Usage location	Fixed use
Receiver Category	1

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification	FCC Part 15 Subpart C The latest version on the first day of the testing period
Title	FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.249 Operation within the bands 902-928MHz, 2400-2483.5MHz, 5725-5875MHz and 24.0-24.25GHz

3.2 Procedures and results

No.	Item	Test Procedure	Specification	Worst margin	Results	Remarks
1	Conducted Emission	ANSI C63.10-2013 6. Standard test methods	Section 15.207(a)	31.37 dB, 0.41288 MHz, AV, Phase N	Complied	-
2	Electric Field Strength of Fundamental Emission	ANSI C63.10-2013 6. Standard test methods	Section 15.249(a)(c)(e)	30.5 dB 24239.0 MHz, Horizontal, PK	Complied	Radiated
3	Electric Field Strength of Spurious Emission	ANSI C63.10-2013 6. Standard test methods 9. Procedures for testing millimeter-wave systems	Section 15.205(a)(b)(d) Section 15.209(a) Section 15.249(a)(c)(d)(e)	4.2 dB 24250.0 MHz, Vertical, AV	Complied	Radiated
4	20dB Bandwidth	ANSI C63.10-2013 6. Standard test methods	FCC 15.215	N/A	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.

FCC Part 15.31 (e)

This EUT provides stable voltage constantly to RF Module regardless of input voltage.
Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

The antenna is not removable from the EUT.
Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

No addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

Measurement uncertainty is not taken into account when stating conformity with a specified requirement.
Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Conducted emission

Item	Frequency range	Unit	Calculated Uncertainty (+/-)
AMN (LISN)	0.009 MHz to 0.15 MHz	dB	3.7
	0.15 MHz to 30 MHz	dB	3.3

Radiated emission

Measurement distance	Frequency range		Unit	Calculated Uncertainty (+/-)
3 m	9 kHz to 30 MHz		dB	3.3
10 m			dB	3.1
3 m	30 MHz to 200 MHz	Horizontal	dB	4.8
		Vertical	dB	5.0
	200 MHz to 1000 MHz	Horizontal	dB	5.1
		Vertical	dB	6.2
10 m	30 MHz to 200 MHz	Horizontal	dB	4.8
		Vertical	dB	4.8
	200 MHz to 1000 MHz	Horizontal	dB	4.9
		Vertical	dB	5.0
3 m	1 GHz to 6 GHz	Test Receiver	dB	5.1
		Spectrum Analyzer	dB	4.9
	6 GHz to 18 GHz	Test Receiver	dB	5.4
		Spectrum Analyzer	dB	5.2
1 m	10 GHz to 18 GHz	Spectrum analyzer	dB	5.0
	18 GHz to 26.5 GHz	Spectrum analyzer	dB	5.6
	26.5 GHz to 40 GHz	Spectrum analyzer	dB	4.9
0.5 m	26.5 GHz to 40 GHz	Spectrum analyzer	dB	4.9
10 m	1 GHz to 18 GHz	Test Receiver	dB	5.4
>= 0.5 m	40 GHz to 50 GHz		dB	4.3
>= 0.5 m	50 GHz to 75 GHz		dB	5.9
>= 0.5 m	75 GHz to 110 GHz		dB	5.7

3.5 Test Location

UL Japan, Inc. Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 Japan

Telephone: +81-596-24-8999

A2LA Certificate Number: 5107.02 / FCC Test Firm Registration Number: 884919

ISED Lab Company Number: 2973C / CAB identifier: JP0002

Test site	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.5 measurement room	6.4 x 6.4 x 3.0	6.4 x 6.4	-	-
No.6 shielded room	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.10 shielded room	3.8 x 2.8 x 2.8	3.8 x 2.8	-	-
No.11 measurement room	4.0 x 3.4 x 2.5	N/A	-	-
No.12 measurement room	2.6 x 3.4 x 2.5	N/A	-	-
Large Chamber	16.9 x 22.1 x 10.17	16.9 x 22.1	-	10 m
Small Chamber	5.3 x 6.69 x 3.59	5.3 x 6.69	-	-

* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 3.0 m for No.1, No.2, No.3, No.4, and No.5 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up.

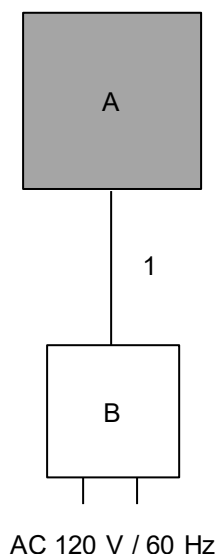
Refer to APPENDIX.

SECTION 4: Operation of EUT during testing

4.1 Operating Modes

Test Item	Mode	Tested frequency [GHz]
- Conducted Emission - Radiated Emission (Electric Field Strength of Spurious Emission) - 20 dB Bandwidth, 99 % Occupied Bandwidth - Duty Cycle	1) Test mode (Frequency sweep)	24.150
- Radiated Emission (Electric Field Strength of Fundamental Emission and Spurious Emission)	2) Test mode (Frequency sweep stopped)	24.059 24.149 24.239
The system was configured in typical fashion (as a customer would normally use it) for testing.		
*Power of the EUT was set by the software as follows; Power Setting: Same as Production model Software: Mode 1): Diag Version: M2 (Date: 2022.10.12, Storage location: EUT memory) Mode 2): CW_24059MHz Version: M2 (Date: 2022.10.12, Storage location: EUT memory) CW_24149MHz Version: M2 (Date: 2022.10.12, Storage location: EUT memory) CW_24239MHz Version: M2 (Date: 2022.10.12, Storage location: EUT memory) *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.		

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Wireless device	CLO-001	S-1639	Nintendo Co., Ltd.	EUT
B	AC Adapter	HAC-002	S-1461	Nintendo Co., Ltd.	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	1.5	Shielded	Shielded	Part of HAC-002

SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80 cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane.

The AC Mains Terminal Continuous Disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

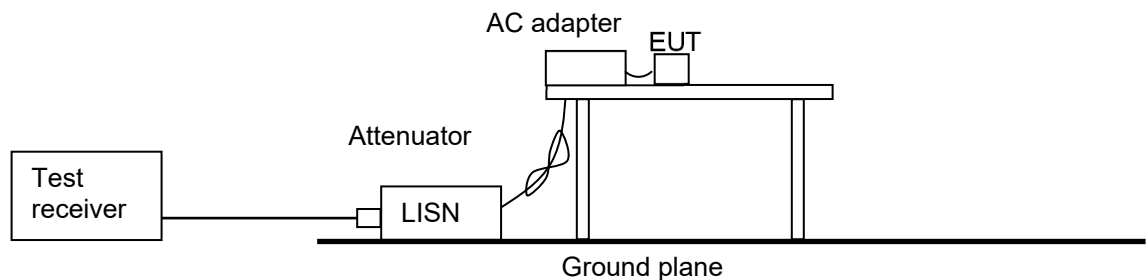
The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	: QP and CISPR AV
Measurement range	: 0.15 MHz to 30 MHz
Test data	: APPENDIX
Test result	: Pass

Figure 1: Test Setup



SECTION 6: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 30 MHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg., 135 deg and 180 deg.) and horizontal polarization.

*Refer to Figure 1 about Direction of the Loop Antenna.

[For 30 MHz to 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz, up to 40 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m (frequency range 9 kHz to 30 MHz: loop antenna was fixed height at 1.0 m) and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear voltage average mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	9 kHz to 150 kHz	150 kHz to 30 MHz	30 MHz to 1 GHz	1 GHz to 40 GHz	
Instrument used	Test Receiver	Test Receiver	Test Receiver	Spectrum Analyzer	
Detector	QP, Average *1)	QP, Average *1)	QP	Peak	Average
IF Bandwidth	BW 200 Hz	BW 9 kHz	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	RBW: 1 MHz VBW: 10 Hz Voltage avg. or RBW: 1 MHz VBW: 1/T Power avg.

*1) Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 m open field test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.

Figure 1: Direction of the Loop Antenna

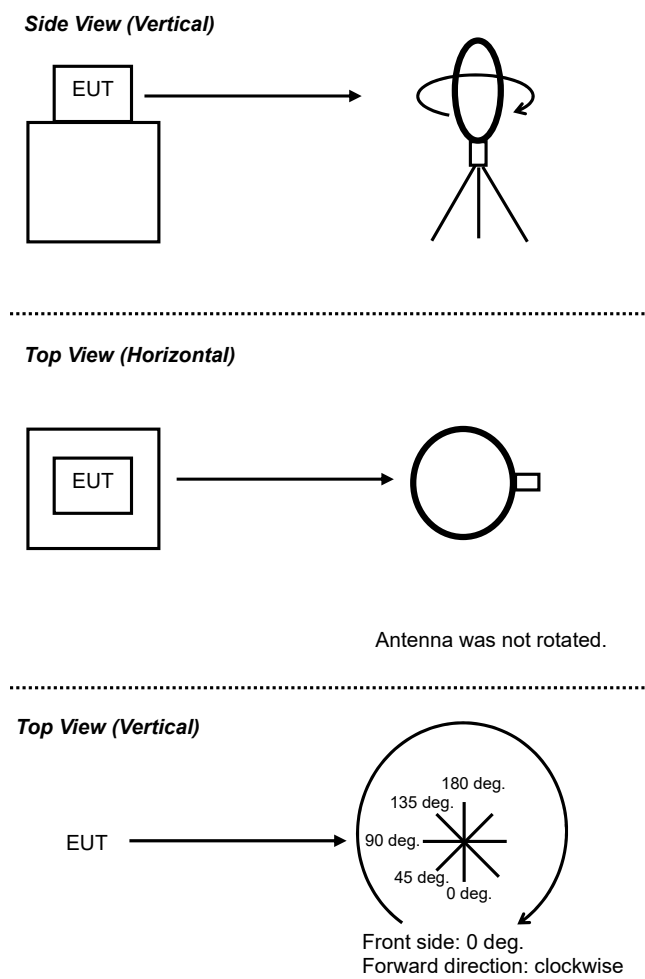
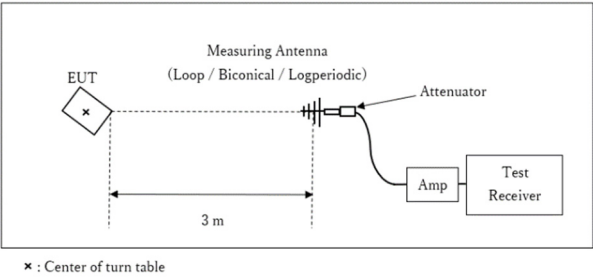


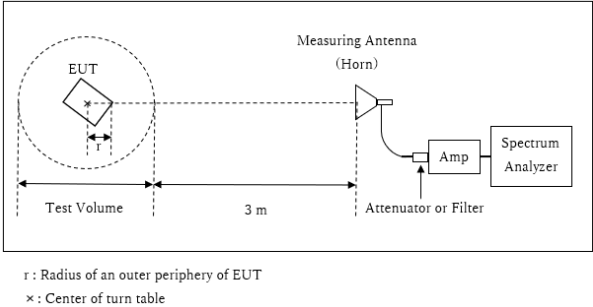
Figure 2: Test Setup

[Test setup]
Below 1 GHz



Test Distance: 3 m

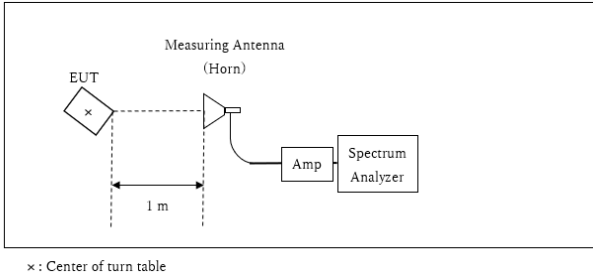
1 GHz to 10 GHz



Distance Factor: $20 \times \log (3.95 \text{ m}^*/3.0 \text{ m}) = 2.4 \text{ dB}$
* Test Distance: $(3 + \text{SVSWR Volume} / 2) - r = 3.95 \text{ m}$

SVSWR Volume: 2 m
(SVSWR Volume has been calibrated based on CISPR 16-1-4.)
 $r = 0.05 \text{ m}$

10 GHz to 40 GHz



Distance Factor: $20 \times \log (1.0 \text{ m}^* / 3.0 \text{ m}) = -9.5 \text{ dB}$
*Test Distance: 1 m

[About fundamental measurement]

The carrier levels were confirmed at maximum direction of transmission. The maximum direction was searched under carefully since beam-widths are narrow.

The carrier levels were measured in the far field. The distance of the far field was calculated from follow equation.

$$r = \frac{2D^2}{\lambda}$$

where

r is the distance from the radiating element of the EUT to the edge of the far field, in m

D is the largest dimension of both the radiating element and the test antenna (horn), in m

(The antenna aperture size of test antenna was used for this calculation.)

λ is the wavelength of the emission under investigation $[300 / f(\text{MHz}) * 10^3]$, in millimeter

Frequency	Wavelength	EUT	Maximum Dimension Test Antenna Local ID MHA-16	Maximum D	Far Field Boundary r
[GHz]	λ [mm]	[m]	[m]	[m]	[m]
24.250	12.4	0.009	0.058	0.058	0.544

[Above 40 GHz]

The test was performed based on “Procedures for testing millimeter-wave systems” of ANSI C63.10-2013.

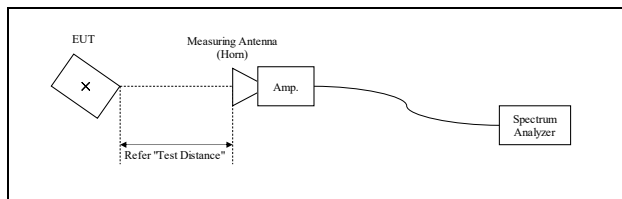
The EUT was placed on an urethane platform, raised 1.5 m above the conducting ground plane. The measurements were performed on handheld method.

Set spectrum analyzer RBW, VBW, span, etc., to the proper values. Note these values. Enable two traces—one set to “clear write,” and the other set to “max hold.” Begin hand-held measurements with the test antenna (horn) at a distance of 1 m from the EUT in a horizontally polarized position. Slowly adjust its position, entirely covering the plane 1 m from the EUT. Observation of the two active traces on the spectrum analyzer will allow refined horn positioning at the point(s) of maximum field intensity. Repeat with the horn in a vertically polarized position. If the emission cannot be detected at 1 m, reduce the RBW to increase system sensitivity. Note the value. If the emission still cannot be detected, move the horn closer to the EUT, noting the distance at which a measurement is made.

Detector	Peak	Average
IF Bandwidth	RBW: 1 MHz VBW: 3 MHz	RBW: 1 MHz VBW: 10 Hz Voltage avg. or RBW: 1 MHz VBW: 1/T Power avg.

[Test setup]

40 GHz to 50 GHz

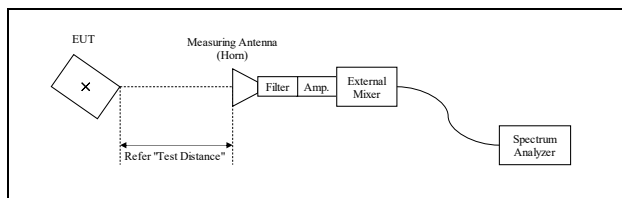


※: Center of turn table

Distance Factor: $20 \times \log (0.50 \text{ m}^* / 3.0 \text{ m}) = -15.6 \text{ dB}$

*Test Distance: 0.50 m

50 GHz to 75 GHz

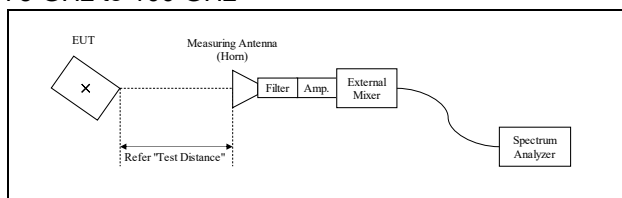


※: Center of turn table

Distance Factor: $20 \times \log (0.75 \text{ m}^* / 3.0 \text{ m}) = -12.0 \text{ dB}$

*Test Distance: 0.75 m

75 GHz to 100 GHz



※: Center of turn table

Distance Factor: $20 \times \log (0.50 \text{ m}^* / 3.0 \text{ m}) = -15.6 \text{ dB}$

*Test Distance: 0.50 m

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

*The result is rounded off, so some differences might be observed.

Measurement range	: 9 kHz to 100 GHz
Test data	: APPENDIX
Test result	: Pass

SECTION 7: 20 dB Bandwidth, 99 % Occupied Bandwidth and Duty Cycle

Test Procedure

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	400 MHz	2 MHz 1 % to 5 % of OBW	6 MHz Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	400 MHz, Enough width to display emission skirts	2 MHz, 1 % to 5 % of OBW	6 MHz, Three times of RBW	Auto	Peak *1)	Max Hold *2)	Spectrum Analyzer
Duty Cycle	-	-	-	40 msec (1 cycle) 10 msec (Tx ON)	-	Single	Oscilloscope

*1) Peak detector was applied as Worst-case measurement.

*2) The measurement was performed with Max Hold since the duty cycle was not 100 %.

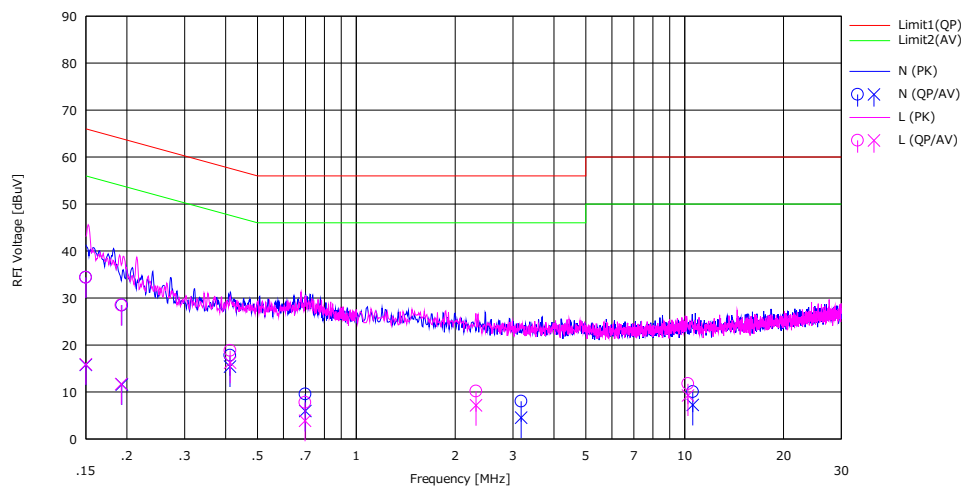
Test data : **APPENDIX**
Test result : **Pass**

APPENDIX 1: Test data

Conducted Emission

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	December 19, 2023
Temperature / Humidity	21 deg. C / 33 % RH
Engineer	Yuichiro Yamazaki
Mode	Mode 1

Limit : FCC_Part 15 Subpart C(15.207)



No.	Freq. [MHz]	Reading		USN [dB]	LOSS [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]			<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.15000	21.10	2.50	0.13	13.14	34.37	15.77	66.00	56.00	31.63	40.23	N	
2	0.19320	15.20	-1.70	0.13	13.14	28.47	11.57	63.90	53.90	35.43	42.33	N	
3	0.41256	4.50	2.10	0.14	13.16	17.80	15.40	57.60	47.60	39.80	32.20	N	
4	0.69912	-3.80	-7.40	0.15	13.19	9.54	5.94	56.00	46.00	46.46	40.06	N	
5	3.17711	-5.60	-9.10	0.27	13.35	8.02	4.52	56.00	46.00	47.98	41.48	N	
6	10.58395	-4.50	-7.30	0.93	13.61	10.04	7.24	60.00	50.00	49.96	42.76	N	
7	0.15000	21.10	2.60	0.14	13.14	34.38	15.88	66.00	56.00	31.62	40.12	L	
8	0.19234	15.20	-1.60	0.13	13.14	28.47	11.67	63.93	53.93	35.46	42.26	L	
9	0.41288	5.50	2.90	0.16	13.16	18.82	16.22	57.59	47.59	38.77	31.37	L	
10	0.69805	-5.60	-9.50	0.18	13.19	7.77	3.87	56.00	46.00	48.23	42.13	L	
11	2.31500	-3.40	-6.40	0.26	13.30	10.16	7.16	56.00	46.00	45.84	38.84	L	
12	10.23395	-2.70	-5.20	0.84	13.60	11.74	9.24	60.00	50.00	48.26	40.76	L	

CHART: WITH FACTOR Peak hold data. CALCULATION : RESULT = READING + LISN + LOSS (CABLE + ATT)
Except for the above table: adequate margin data below the limits.

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place	Ise EMC Lab.					
Semi Anechoic Chamber	No.2	No.3	No.3	No.3	No.3	No.4
Date	December 14, 2023	December 15, 2023	December 18, 2023	December 18, 2023	December 19, 2023	April 1, 2024
Temperature / Humidity	23 deg. C / 43 % RH	21 deg. C / 41 % RH	22 deg. C / 40 % RH	20 deg. C / 37 % RH	21 deg. C / 42 % RH	20 deg. C / 42 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki	Junki Nagatomi	Yuichiro Yamazaki	Junki Nagatomi	Junki Nagatomi
	(10 GHz to 18 GHz) (26.5 GHz to 40 GHz) (75 GHz to 100 GHz)	(40 GHz to 75 GHz)	(18 GHz to 26.5 GHz)	(1 GHz to 10 GHz) (9 kHz to 30 MHz)	(30 MHz to 1000 MHz)	(18 GHz to 26.5 GHz)
Mode	Mode 2 (Tx 24.059 GHz)					

[Fundamental and band-edge]

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	24000.0	46.2	33.1	38.7	-0.3	31.3	-	53.3	40.3	73.9	53.9	20.6	13.6	Floor noise
Hori.	24059.0	89.7	89.4	40.3	-1.4	31.3	-	97.3	97.0	127.9	107.9	30.6	10.9	
Vert.	24000.0	46.1	33.1	38.7	-0.3	31.3	-	53.2	40.3	73.9	53.9	20.7	13.6	Floor noise
Vert.	24059.0	89.5	89.2	40.3	-1.4	31.3	-	97.1	96.8	127.9	107.9	30.8	11.1	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Distance factor (above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 18 GHz to 26.5 GHz $20\log(1.00\text{ m} / 3.00\text{ m}) = -9.5\text{ dB}$

[Spurious emissions other than above]

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	48118.0	51.4	43.6	41.7	-7.4	32.7	-	53.0	45.2	87.9	67.9	34.9	22.7	
Hori.	72177.0	38.3	26.0	43.1	5.5	21.0	-	65.8	53.5	87.9	67.9	22.1	14.4	
Hori.	96236.0	50.5	39.0	45.7	-4.5	35.2	-	56.5	45.0	73.9	53.9	17.4	8.9	
Vert.	48118.0	51.2	42.9	41.7	-7.4	32.7	-	52.7	44.5	87.9	67.9	35.2	23.4	
Vert.	72177.0	38.5	26.3	43.1	5.5	21.0	-	66.0	53.8	87.9	67.9	21.9	14.1	
Vert.	96236.0	50.6	39.2	45.7	-4.5	35.2	-	56.6	45.2	73.9	53.9	17.3	8.7	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + Mixer (above 50 GHz) + Distance factor (above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

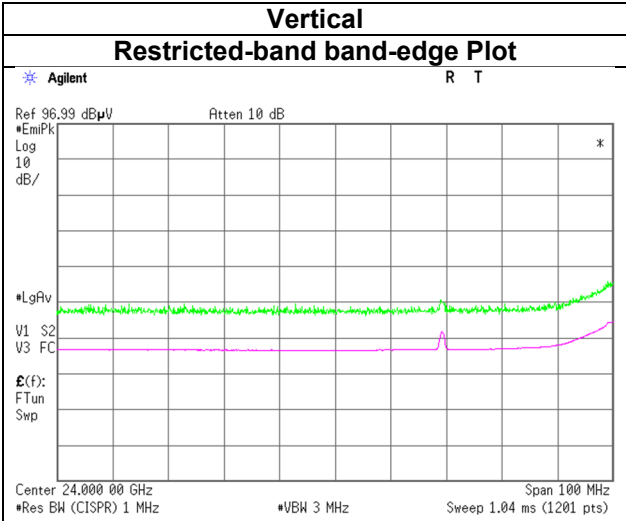
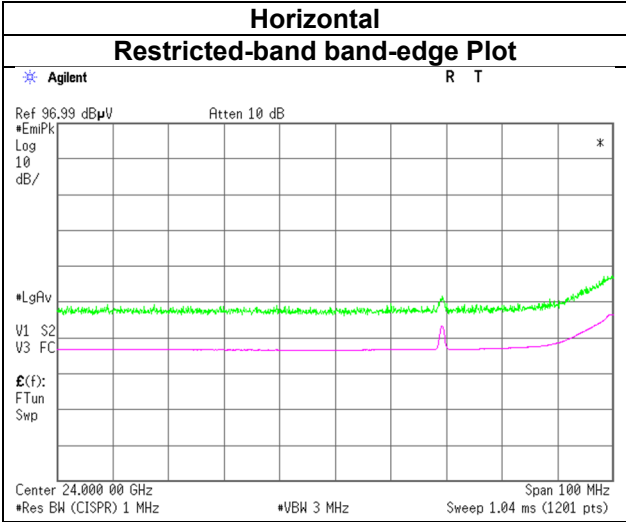
*QP detector was used up to 1GHz.

Distance factor:

1 GHz to 10 GHz	$20\log(3.95\text{ m} / 3.00\text{ m}) = 2.4\text{ dB}$
10 GHz to 40 GHz	$20\log(1.00\text{ m} / 3.00\text{ m}) = -9.5\text{ dB}$
40 GHz to 50 GHz	$20\log(0.50\text{ m} / 3.00\text{ m}) = -15.6\text{ dB}$
50 GHz to 75 GHz	$20\log(0.75\text{ m} / 3.00\text{ m}) = -12.0\text{ dB}$
75 GHz to 100 GHz	$20\log(0.50\text{ m} / 3.00\text{ m}) = -15.6\text{ dB}$

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)
(Reference Plot for band-edge)

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	December 18, 2023
Temperature / Humidity	22 deg. C / 40 % RH
Engineer	Junki Nagatomi
Mode	Mode 2 (Tx 24.059 GHz)



* Final result of restricted band edge was shown in tabular data.

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place	Ise EMC Lab.					
Semi Anechoic Chamber	No.2	No.3	No.3	No.3	No.3	No.4
Date	December 14, 2023	December 15, 2023	December 18, 2023	December 18, 2023	December 19, 2023	April 1, 2024
Temperature / Humidity	23 deg. C / 43 % RH	21 deg. C / 41 % RH	22 deg. C / 40 % RH	20 deg. C / 37 % RH	21 deg. C / 42 % RH	20 deg. C / 42 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki	Junki Nagatomi	Yuichiro Yamazaki	Junki Nagatomi	Junki Nagatomi
	(10 GHz to 18 GHz) (26.5 GHz to 40 GHz) (75 GHz to 100 GHz)	(40 GHz to 75 GHz)	(18 GHz to 26.5 GHz)	(1 GHz to 10 GHz) (9 kHz to 30 MHz)	(30 MHz to 1000 MHz)	(18 GHz to 26.5 GHz)
Mode	Mode 2 (Tx 24.149 GHz)					

[Fundamental]

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	24149.0	89.9	89.6	40.3	-1.4	31.5	-	97.4	97.1	127.9	107.9	30.6	10.9	
Vert.	24149.0	89.6	89.3	40.3	-1.4	31.5	-	97.1	96.8	127.9	107.9	30.9	11.2	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Distance factor (above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 18 GHz to 26.5 GHz $20\log(1.00\text{ m} / 3.00\text{ m}) = -9.5\text{ dB}$

[Spurious emissions other than above]

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	48298.0	51.1	43.8	41.7	-7.4	32.6	-	52.8	45.5	87.9	67.9	35.1	22.4	
Hori.	72447.0	38.2	25.8	43.1	5.8	21.2	-	65.9	53.5	87.9	67.9	22.0	14.4	
Hori.	96596.0	50.3	38.9	45.6	-4.5	35.4	-	56.1	44.7	73.9	53.9	17.8	9.2	
Vert.	48298.0	51.7	43.5	41.7	-7.4	32.6	-	53.4	45.2	87.9	67.9	34.5	22.7	
Vert.	72447.0	38.3	26.2	43.1	5.8	21.2	-	66.0	53.8	87.9	67.9	21.9	14.1	
Vert.	96596.0	50.3	39.0	45.6	-4.5	35.4	-	56.1	44.8	73.9	53.9	17.8	9.1	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + Mixer (above 50 GHz) + Distance factor (above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

Distance factor: 1 GHz to 10 GHz $20\log(3.95\text{ m} / 3.00\text{ m}) = 2.4\text{ dB}$
10 GHz to 40 GHz $20\log(1.00\text{ m} / 3.00\text{ m}) = -9.5\text{ dB}$
40 GHz to 50 GHz $20\log(0.50\text{ m} / 3.00\text{ m}) = -15.6\text{ dB}$
50 GHz to 75 GHz $20\log(0.75\text{ m} / 3.00\text{ m}) = -12.0\text{ dB}$
75 GHz to 100 GHz $20\log(0.50\text{ m} / 3.00\text{ m}) = -15.6\text{ dB}$

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place	Ise EMC Lab.					
Semi Anechoic Chamber	No.2	No.3	No.3	No.3	No.3	No.4
Date	December 14, 2023	December 15, 2023	December 18, 2023	December 18, 2023	December 19, 2023	April 1, 2024
Temperature / Humidity	23 deg. C / 43 % RH	21 deg. C / 41 % RH	22 deg. C / 40 % RH	20 deg. C / 37 % RH	21 deg. C / 42 % RH	20 deg. C / 42 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki	Junki Nagatomi	Yuichiro Yamazaki	Junki Nagatomi	Junki Nagatomi
	(10 GHz to 18 GHz) (26.5 GHz to 40 GHz) (75 GHz to 100 GHz)	(40 GHz to 75 GHz)	(18 GHz to 26.5 GHz)	(1 GHz to 10 GHz) (9 kHz to 30 MHz)	(30 MHz to 1000 MHz)	(18 GHz to 26.5 GHz)
Mode	Mode 2 (Tx 24.239 GHz)					

[Fundamental, band-edge]

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	24239.0	90.1	90.1	40.3	-1.3	31.7	-	97.4	97.4	127.9	107.9	30.5	10.5	
Hori.	24250.0	55.0	42.1	38.7	-0.2	31.2	-	62.4	49.5	73.9	53.9	11.5	4.4	
Hori.	24279.2	49.0	39.7	38.8	-0.2	31.2	-	56.4	47.1	73.9	53.9	17.5	6.8	
Vert.	24239.0	89.6	89.2	40.3	-1.3	31.7	-	96.9	96.5	127.9	107.9	31.0	11.4	
Vert.	24250.0	55.4	42.4	38.7	-0.2	31.2	-	62.7	49.7	73.9	53.9	11.2	4.2	
Vert.	24279.2	48.9	40.5	38.8	-0.2	31.2	-	56.3	47.9	73.9	53.9	17.6	6.0	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Distance factor (above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 18 GHz to 26.5 GHz 20log (1.00 m / 3.00 m) = -9.5 dB

[Spurious emissions other than above]

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	48478.0	51.3	43.3	41.7	-7.4	32.5	-	53.2	45.2	87.9	67.9	34.7	22.2	
Hori.	72717.0	38.2	25.7	43.1	6.2	21.4	-	66.0	53.6	87.9	67.9	21.9	14.3	
Hori.	96956.0	50.7	39.0	45.6	-4.4	35.6	-	56.3	44.6	73.9	53.9	17.6	9.3	
Vert.	48478.0	51.3	43.8	41.7	-7.4	32.5	-	53.2	45.7	87.9	67.9	34.7	22.2	
Vert.	72717.0	38.3	26.1	43.1	6.2	21.4	-	66.2	53.9	87.9	67.9	21.8	14.0	
Vert.	96956.0	50.6	38.9	45.6	-4.4	35.6	-	56.2	44.5	73.9	53.9	17.7	9.4	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + Mixer (above 50 GHz) + Distance factor (above 1 GHz)) - Gain(Amplifier)

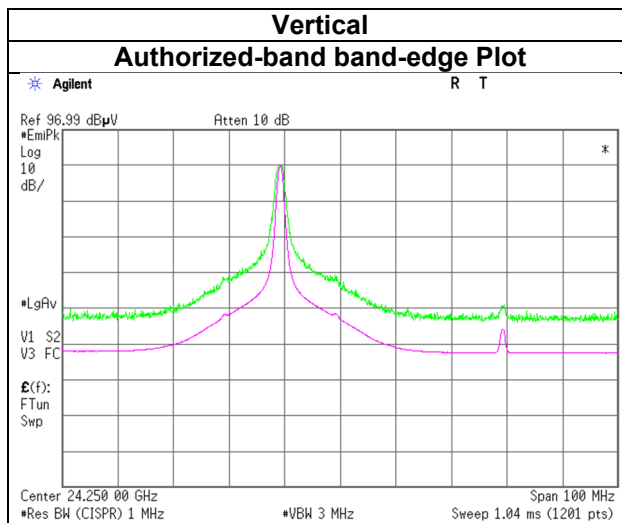
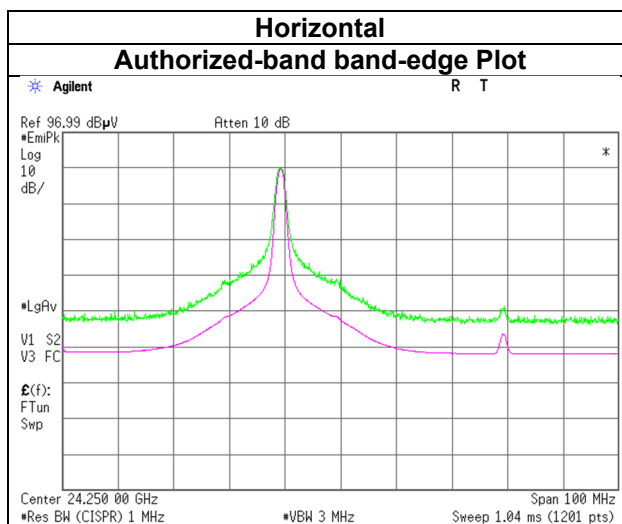
*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

Distance factor: 1 GHz to 10 GHz 20log (3.95 m / 3.00 m) = 2.4 dB
10 GHz to 40 GHz 20log (1.00 m / 3.00 m) = -9.5 dB
40 GHz to 50 GHz 20log (0.50 m / 3.00 m) = -15.6 dB
50 GHz to 75 GHz 20log (0.75 m / 3.00 m) = -12.0 dB
75 GHz to 100 GHz 20log (0.50 m / 3.00 m) = -15.6 dB

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission) (Reference Plot for band-edge)

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	December 18, 2023
Temperature / Humidity	22 deg. C / 40 % RH
Engineer	Junki Nagatomi
Mode	Mode 2 (Tx 24.239 GHz)



* Final result of restricted band edge was shown in tabular data.

Radiated Emission (Electric Field Strength of Spurious Emission)

Test place	Ise EMC Lab.					
Semi Anechoic Chamber	No.2	No.3	No.3	No.3	No3	No.4
Date	December 14, 2023	December 15, 2023	December 18, 2023	December 18, 2023	December 19, 2023	April 1, 2024
Temperature / Humidity	23 deg. C / 43 % RH	21 deg. C / 41 % RH	22 deg. C / 40 % RH	20 deg. C / 37 % RH	21 deg. C / 42 % RH	20 deg. C / 42 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki	Junki Nagatomi	Yuichiro Yamazaki	Junki Nagatomi	Junki Nagatomi
	(10 GHz to 18 GHz) (26.5 GHz to 40 GHz) (75 GHz to 100 GHz)	(40 GHz to 75 GHz)	(18 GHz to 26.5 GHz)	(1 GHz to 10 GHz) (9 kHz to 30 MHz)	(30 MHz to 1000 MHz)	(18 GHz to 26.5 GHz)
Mode	Mode 1					

Below 1 GHz

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	49.1	28.2	-	10.0	7.2	32.2	13.3	-	40.0	-	26.7	-	
Hori.	52.3	24.1	-	9.7	7.3	32.2	8.9	-	40.0	-	31.1	-	
Hori.	72.8	33.8	-	9.0	7.6	32.1	18.2	-	40.0	-	21.8	-	
Hori.	85.4	23.5	-	9.2	7.7	32.1	8.3	-	40.0	-	31.7	-	
Hori.	153.1	26.2	-	12.2	8.5	32.1	14.8	-	43.5	-	28.7	-	
Hori.	330.1	25.2	-	14.5	9.9	32.0	17.6	-	46.0	-	28.5	-	
Vert.	49.1	42.0	-	10.0	7.2	32.2	27.1	-	40.0	-	12.9	-	
Vert.	51.6	37.3	-	9.8	7.3	32.2	22.2	-	40.0	-	17.9	-	
Vert.	72.3	35.8	-	9.0	7.6	32.2	20.2	-	40.0	-	19.8	-	
Vert.	95.1	31.2	-	9.7	7.8	32.1	16.6	-	43.5	-	26.9	-	
Vert.	149.4	33.7	-	12.1	8.4	32.1	22.2	-	43.5	-	21.4	-	
Vert.	330.1	21.7	-	14.5	9.9	32.0	14.1	-	46.0	-	32.0	-	

Result = Reading + Ant Factor + Loss (Cable + Attenuator) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*QP detector was used up to 1GHz.

Above 1 GHz

Polarity [Hori/Vert]	Frequency [MHz]	Reading (QP / PK) [dBuV]	Reading (AV) [dBuV]	Ant. Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (QP / PK) [dBuV/m]	Result (AV) [dBuV/m]	Limit (QP / PK) [dBuV/m]	Limit (AV) [dBuV/m]	Margin (QP / PK) [dB]	Margin (AV) [dB]	Remark
Hori.	24000.0	50.5	34.6	38.7	-0.3	31.3	-	57.6	41.7	73.9	53.9	16.3	12.2	
Hori.	24250.0	55.9	38.3	38.7	-0.2	31.2	-	63.3	45.6	73.9	53.9	10.6	8.3	
Vert.	24000.0	50.2	34.8	38.7	-0.3	31.3	-	57.4	41.9	73.9	53.9	16.5	12.0	
Vert.	24250.0	56.0	38.6	38.7	-0.2	31.2	-	63.3	46.0	73.9	53.9	10.6	7.9	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + Mixer (above 50 GHz) + Distance factor (above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

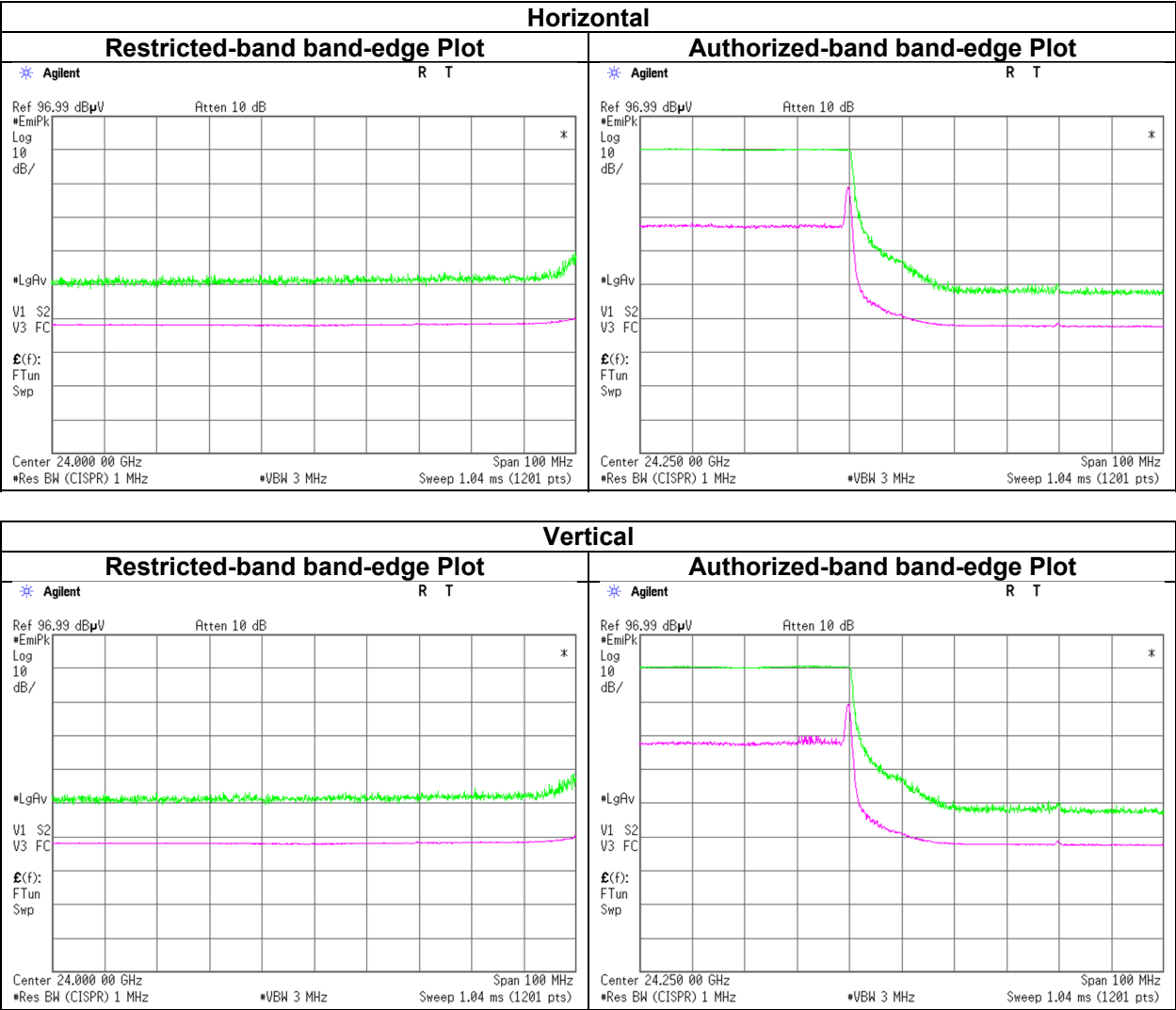
*QP detector was used up to 1GHz.

Distance factor:

1 GHz to 10 GHz	$20\log(3.95\text{ m} / 3.00\text{ m}) = 2.4\text{ dB}$
10 GHz to 40 GHz	$20\log(1.00\text{ m} / 3.00\text{ m}) = -9.5\text{ dB}$
40 GHz to 50 GHz	$20\log(0.50\text{ m} / 3.00\text{ m}) = -15.6\text{ dB}$
50 GHz to 75 GHz	$20\log(0.75\text{ m} / 3.00\text{ m}) = -12.0\text{ dB}$
75 GHz to 100 GHz	$20\log(0.50\text{ m} / 3.00\text{ m}) = -15.6\text{ dB}$

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)
(Reference Plot for band-edge)

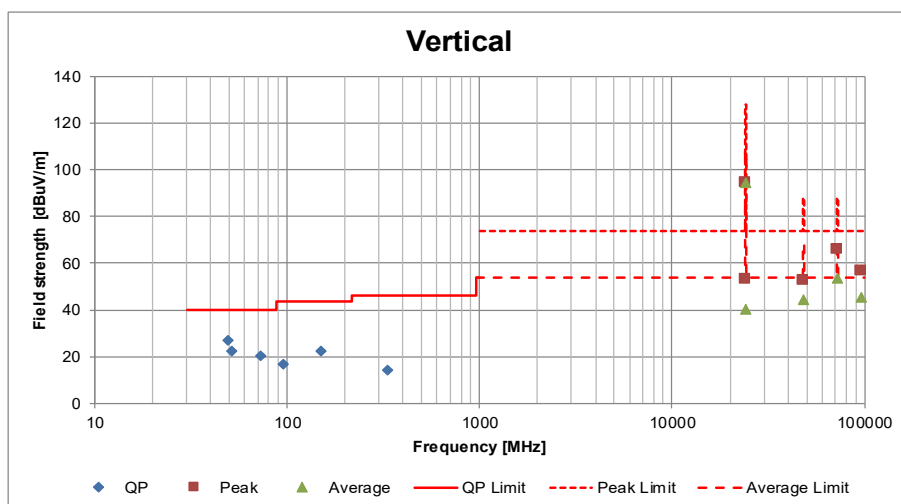
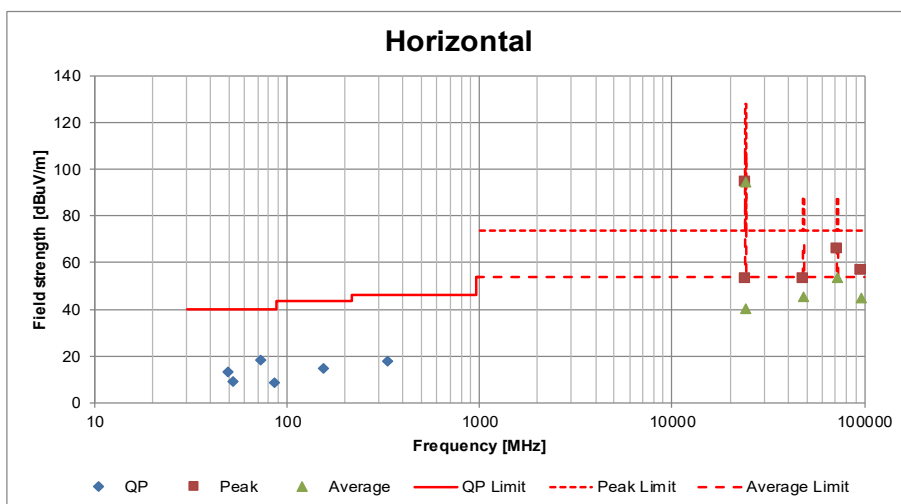
Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	December 18, 2023
Temperature / Humidity	22 deg. C / 40 % RH
Engineer	Junki Nagatomi
	(18 GHz to 26.5 GHz)
Mode	Mode 1



* Final result of restricted band edge was shown in tabular data.

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission) (Plot data, Worst case)

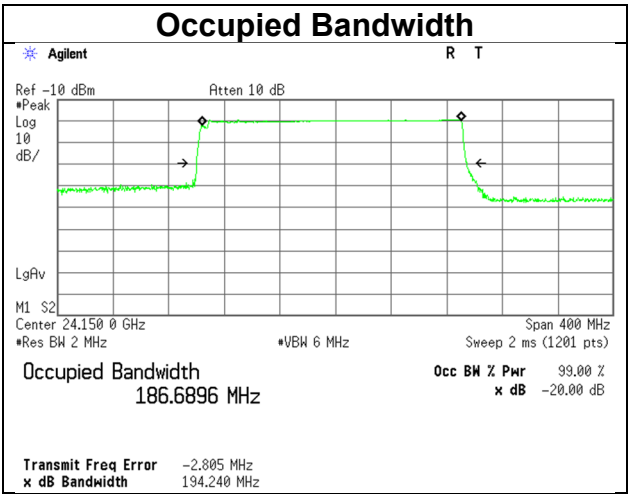
Test place	Ise EMC Lab.					
Semi Anechoic Chamber	No.2	No.3	No.3	No.3	No3	No.4
Date	December 14, 2023	December 15, 2023	December 18, 2023	December 18, 2023	December 19, 2023	April 1, 2024
Temperature / Humidity	23 deg. C / 43 % RH	21 deg. C / 41 % RH	22 deg. C / 40 % RH	20 deg. C / 37 % RH	21 deg. C / 42 % RH	20 deg. C / 42 % RH
Engineer	Yuichiro Yamazaki	Yuichiro Yamazaki	Junki Nagatomi	Yuichiro Yamazaki	Junki Nagatomi	Junki Nagatomi
	(10 GHz to 18 GHz) (26.5 GHz to 40 GHz) (75 GHz to 100 GHz)	(40 GHz to 75 GHz)	(18 GHz to 26.5 GHz)	(1 GHz to 10 GHz) (9 kHz to 30 MHz)	(30 MHz to 1000 MHz)	(18 GHz to 26.5 GHz)
Mode	Mode 2 (Tx 24.239 GHz)					



20 dB Bandwidth, 99 % Occupied Bandwidth

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.2
Date	December 13, 2023
Temperature / Humidity	21 deg. C / 43 % RH
Engineer	Junki Nagatomi
Mode	Mode 1

Frequency [GHz]	99% Occupied Bandwidth [MHz]	-20 dB Bandwidth [MHz]
24.150	186.6896	194.240



Duty Cycle

Test place	Ise EMC Lab.
Semi Anechoic Chamber	No.3
Date	December 19, 2023
Temperature / Humidity	21 deg. C / 33 % RH
Engineer	Yuichiro Yamazaki
Mode	Mode 1

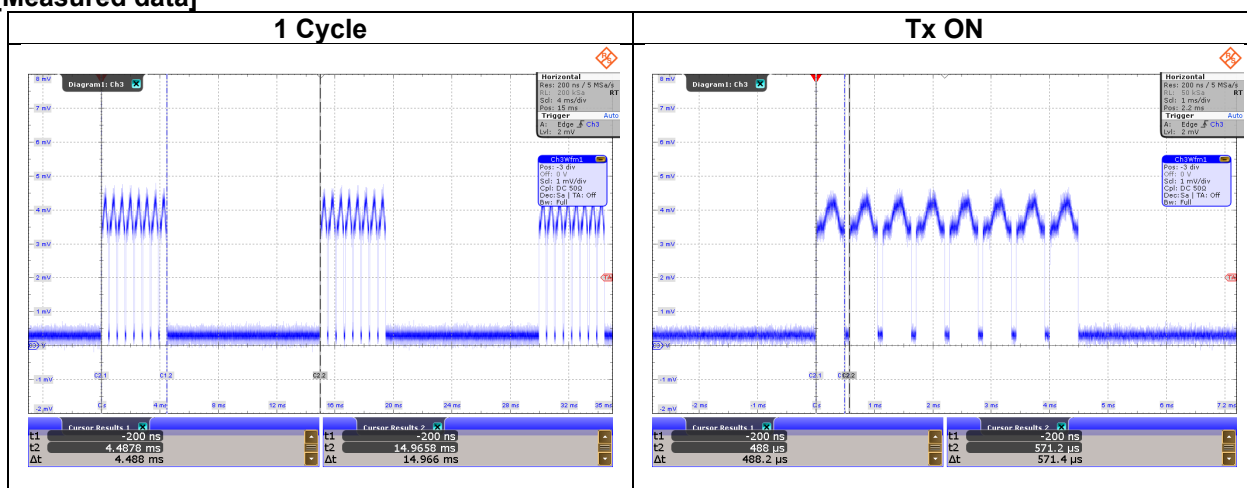
Data	1 cycle time [ms]	Tx On time (Once) [us]	Number of repetitions of Tx On	Tx On time (Total) [us]	Duty factor [dB]	Remarks
Declared	15.000	470.0	8	3760.0	-12.02	-
Measured	14.966	488.2	8	3905.6	-11.67	-

Calculation:

$Tx\ On\ time(Total) = Tx\ On\ time(Once) * Number\ of\ repetitions\ of\ Tx\ On$

$Duty\ factor = 20 * \log((Tx\ On\ time(Total)) / (1\ cycle\ time))$

[Measured data]



APPENDIX 2: Test instruments

Test equipment (1/2)

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
CE	141216	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM14/ suciform141-PE/ 421-010/RFM-E321(SW)	-/00640	07/25/2023	12
CE	141248	Attenuator	JFW Industries, Inc.	50FP-013H2 N	-	12/08/2023	12
CE	141358	LISN(AMN)	Schwarzbeck Mess- Elektronik OHG	NSLK8127	8127-730	07/13/2023	12
CE	141532	DIGITAL HITESTER	HIOKI E.E. CORPORATION	3805	051201197	01/31/2024	12
CE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	05/17/2023	12
CE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/11/2023	24
CE	142183	Measure	KOMELON	KMC-36	-	10/20/2023	12
CE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
CE	244709	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202103	01/25/2024	12
RE	141216	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W/SFM14/ suciform141-PE/ 421-010/RFM-E321(SW)	-/00640	07/25/2023	12
RE	141227	Microwave Cable	Junkosha	MMX221- 00500DMSDMS	1502S305	03/04/2024	12
RE	141266	Logperiodic Antenna (200-1000MHz)	Schwarzbeck Mess- Elektronik OHG	VUSLP9111B	9111B-191	08/10/2023	12
RE	141393	Microwave Cable	Junkosha	MWX221	1604S254(1 m) / 1608S088(5 m)	08/01/2023	12
RE	141503	Horn Antenna 18-26.5GHz	EMCO	3160-09	1265	06/23/2023	12
RE	141504	Horn Antenna 26.5-40GHz	EMCO	3160-10	1150	09/21/2023	12
RE	141507	Horn Antenna 1-18GHz	Schwarzbeck Mess- Elektronik OHG	BBHA9120D	258	11/20/2023	12
RE	141512	Horn Antenna 1-18GHz	Schwarzbeck Mess- Elektronik OHG	BBHA9120D	254	10/17/2023	12
RE	141513	Horn Antenna 15-40GHz	Schwarzbeck Mess- Elektronik OHG	BBHA9170	BBHA9170306	07/19/2023	12
RE	141532	DIGITAL HITESTER	HIOKI E.E. CORPORATION	3805	051201197	01/31/2024	12
RE	141542	Digital Tester	Fluke Corporation	FLUKE 26-3	78030611	08/01/2023	12
RE	141545	DIGITAL HITESTER	HIOKI E.E. CORPORATION	3805	51201148	02/01/2024	12
RE	141579	Pre Amplifier	Keysight Technologies Inc	8449B	3008A02142	02/17/2024	12
RE	141580	MicroWave System Amplifier	Keysight Technologies Inc	83017A	MY39500779	03/08/2024	12
RE	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/17/2024	12
RE	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	04/05/2023	12
RE	141884	Spectrum Analyzer	Keysight Technologies Inc	E4448A	MY44020357	03/19/2024	12
RE	141885	Spectrum Analyzer	Keysight Technologies Inc	E4448A	US44300523	11/29/2023	12
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	05/17/2023	12
RE	141962	Digital Oscilloscope	Rohde & Schwarz	RTO1004	200355	05/16/2023	12
RE	142004	AC2_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	12/12/2023	24
RE	142006	AC2_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-06902	10/20/2023	12
RE	142008	AC3_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/11/2023	24
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	12/13/2023	24

Test equipment (2/2)

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
RE	142013	AC3_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	10/18/2023	12
RE	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	10/11/2023	12
RE	142032	Microwave Cable	Huber+Suhner	SUCOFLEX102	37511/2	-	-
RE	142033	Microwave Cable	Huber+Suhner	SUCOFLEX102	37512/2	-	-
RE	142041	Horn Antenna	Oshima Prototype Engineering Co.	A16-187	1	09/05/2023	12
RE	142047	Preselected Millimeter Mixer	Keysight Technologies Inc	11974V-E01	3001A00412	11/14/2023	12
RE	142055	Power Amplifier	SAGE Millimeter, Inc.	SBP-5037532015-1515-N1	11599-01	03/15/2024	12
RE	142152	Loop Antenna	Rohde & Schwarz	HFH2-Z2	836553/009	10/17/2023	12
RE	142183	Measure	KOMELON	KMC-36	-	10/20/2023	12
RE	142228	Measure, Tape, Steel	KOMELON	KMC-36	-	-	-
RE	142230	Measure, Tape, Steel	KOMELON	KMC-36	-	-	-
RE	142314	Attenuator	Pasternack Enterprises	PE7390-6	D/C 1504	06/23/2023	12
RE	142529	Detector	HEROTEK, INC.	DT1840P	484823	-	-
RE	151897	Microwave Cable	Huber+Suhner	SF101EA/11PC24/11PC24/2.5M	SN MY1726/1EA	04/11/2023	12
RE	159670	Coaxial Cable	UL Japan	-	-	11/21/2023	12
RE	159919	Power Amplifier	SAGE Millimeter, Inc.	SBP-4035033018-2F2F-S1	12559-01	06/19/2023	12
RE	178648	EMI measurement program	TSJ (Techno Science Japan)	TEPTO-DV	-	-	-
RE	180544	Horn Antenna	SAGE Millimeter, Inc.	SAZ-2410-10-S1	17343-01	06/21/2023	12
RE	180607	Power Amplifier	SAGE Millimeter, Inc.	SBP-7531142515-1010-E1	17343-01	09/22/2023	12
RE	180634	Horn Antenna	SAGE Millimeter, Inc.	SAZ-2410-15-S1	17343-01	06/20/2023	12
RE	182484	Signal Analyzer	Keysight Technologies Inc	N9030B	MY57143159	04/14/2023	12
RE	197990	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	VHBB 9124 + BBA 9106	01365	11/29/2023	12
RE	237927	Broadband Amplifier	ERAVANT	SBB-0115033218-2F2F-E3	27554-01	07/10/2023	12
RE	240023	Microwave Cable	Huber+Suhner	SF126E/11PC35/11PC35/1000MM,5000MM	537060/126E / 537075/126E	09/08/2023	12
RE	244707	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202102	01/25/2024	12
RE	244709	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202103	01/25/2024	12
RE	244710	Thermo-Hygrometer	HIOKI E.E. CORPORATION	LR5001	231202104	01/25/2024	12
RE	142048	Harmonic Mixer	Keysight Technologies Inc	11970W	2521 A01909	09/22/2023	12

*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

Test item:

CE: Conducted emission

RE: Radiated emission, 20 dB bandwidth and Duty cycle